4612



Data Sheet

January 1999 File Number

Radiation Hardened Octal Three-State Buffer/Line Driver

Harris' Satellite Applications Flow[™] (SAF) devices are fully tested and guaranteed to 100kRAD total dose. These QML Class T devices are processed to a standard flow intended to meet the cost and shorter lead-time needs of large volume satellite manufacturers, while maintaining a high level of reliability.

The Harris ACTS541T is a Radiation Hardened Octal Buffer/Line Driver, with three-state outputs. The output enable pins $\overline{OE1}$, $\overline{OE2}$ control the three-state outputs. If either enable is high the output will be in a high impedance state. For data output both enables must be low.

Specifications

Specifications for Rad Hard QML devices are controlled by the Defense Supply Center in Columbus (DSCC). The SMD numbers listed below must be used when ordering.

Detailed Electrical Specifications for the ACTS541T are contained in SMD 5962-96726. A "hot-link" is provided from our website for downloading.

http://www.semi.harris.com/families/smdrh.htm

Harris' Quality Management Plan (QM Plan), listing all Class T screening operations, is also available on our website. http://www.semi.harris.com/quality/manuals.htm

Ordering Information

ORDERING NUMBER	PART NUMBER	TEMP. RANGE (^o C)
5962R9672602TRC	ACTS541DTR-02	-55 to 125
ACTS541D/Sample-02	ACTS541D/Sample-02	25
5962R9672602TXC	ACTS541KTR-02	-55 to 125
ACTS541K/Sample-02	ACTS541K/Sample-02	25

NOTE: *Minimum order quantity for -T is 1000 units* Orders must be placed through Harris Sales or Rep Offices.

Features

- QML Class T, Per MIL-PRF-38535
- Radiation Performance
 - Gamma Dose (γ) 1 x 10⁵ RAD(Si)
 - Latch-Up Free Under Any Conditions
 - Single Event Upset (SEU) Immunity: <1 x 10⁻¹⁰ Errors/Bit/Day (Typ)
 - SEU LET Threshold>100 MEV-cm²/mg
- 1.25 Micron Radiation Hardened SOS CMOS
- Significant Power Reduction Compared to ALSTTL Logic
- DC Operating Voltage Range 4.5V to 5.5V
- Input Logic Levels
 - V_{IL} = 0.8V Max
 - V_{IH} = VCC/2 Min
- Fast Propagation Delay 21ns (Max), 14ns (Typ)

Pinouts

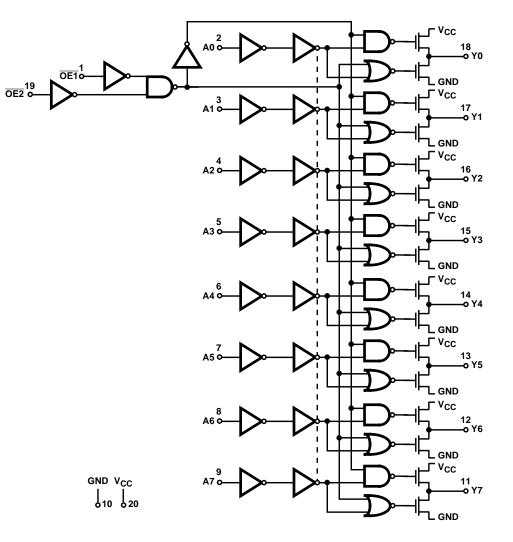
ACTS541T (SBDIP),	CDIP2-T20
TOP VIEW	/

OE1 1	20	Vcc
A0 2	19	OE2
A1 3	18	Y0
A2 4	17	Y1
A3 5	16	Y2
A4 6	15	Y3
A5 7	14	Y4
A6 8	13	Y5
A7 9	12	Y6
GND 10	11	Y7

ACTS541T (FLATPACK), CDFP4-F20 TOP VIEW

	1●	20	
	2	19	
	3	18	
	4	17	
A3 🔁 🏹	5	16	
	6	15	
A5	7	14	
	8	13	
	9	12	→ Y6
	10	11	

Functional Diagram



TRUTH	TABLE

INPUTS		OUTPUTS	
OE1	OE2	An	Yn
L	L	Н	Н
L	L	L	L
н	Х	Х	Z
X	Н	Х	Z

NOTE: L = Low Logic Level, H = High Logic Level, Z = High Impedance.

Die Characteristics

DIE DIMENSIONS:

(2600μm x 2600μm x 533μm ±51μm) 102 x 102 x 21mils ±2mil

METALLIZATION:

Type: Al Si Cu Thickness: 10.0kÅ ±2kÅ

SUBSTRATE POTENTIAL:

Unbiased (Silicon on Sapphire) Bond Pad #20 (V_{CC}) First

BACKSIDE FINISH:

Sapphire

Metallization Mask Layout

PASSIVATION:

Type: Silox (S_iO₂) Thickness: 8.0kÅ ±1.0kÅ

WORST CASE CURRENT DENSITY:

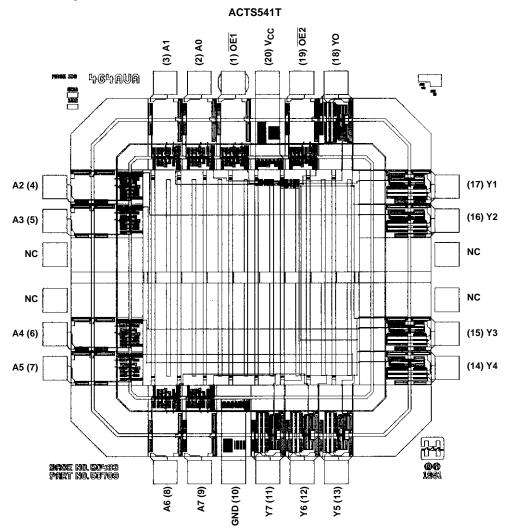
< 2.0e5 A/cm²

TRANSISTOR COUNT:

182

PROCESS:

CMOS SOS



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